

Special Topics on Basic EECS I

VLSI Devices

Lecture 12

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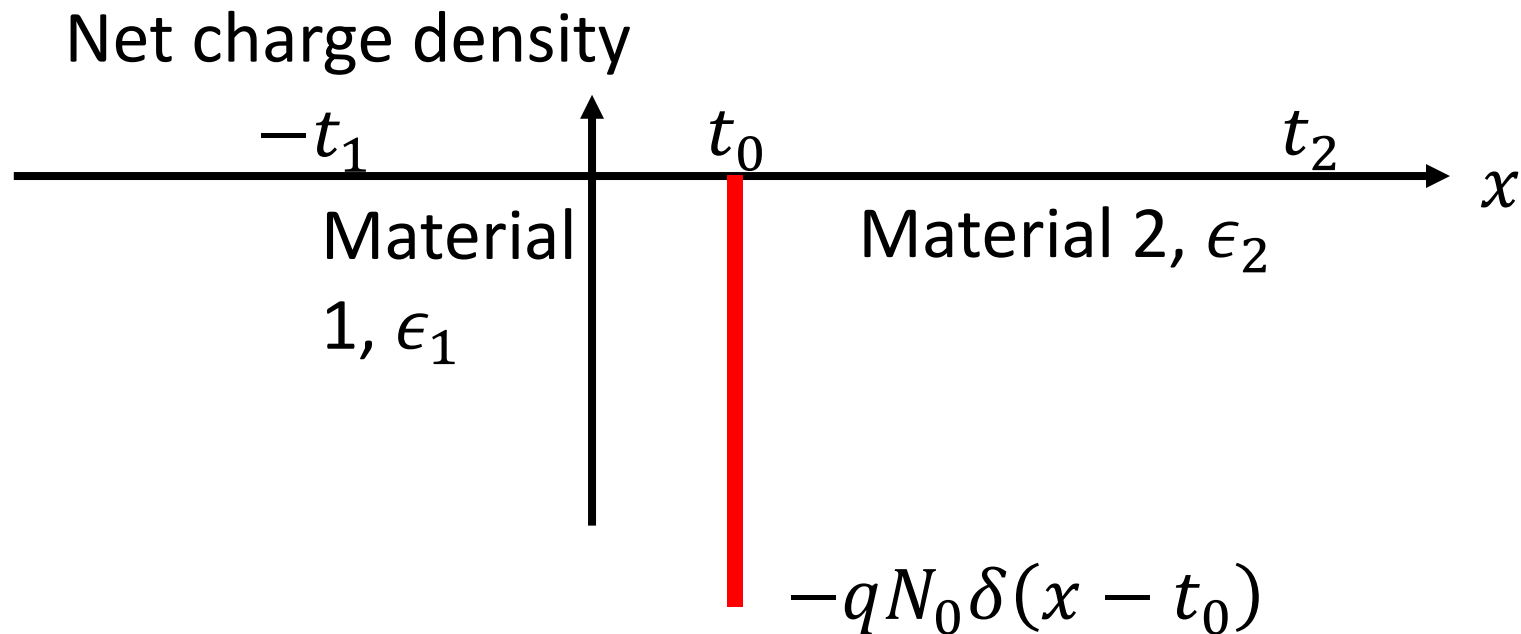
Homework#3

- Solve the Poisson equation, when the interface occurs at $x = 0$.

- Two boundary conditions

$$\phi(-t_1) = \phi_1, \quad \phi(t_1) = \phi_2$$

- Except for a sheet charge at $x = t_0$, no net charge



Continuity equations

- (Change of electron number) = (Net incoming-flux integrated over surface)

– Therefore,

$$\frac{\partial n}{\partial t} = -\nabla \cdot \mathbf{F}_n$$

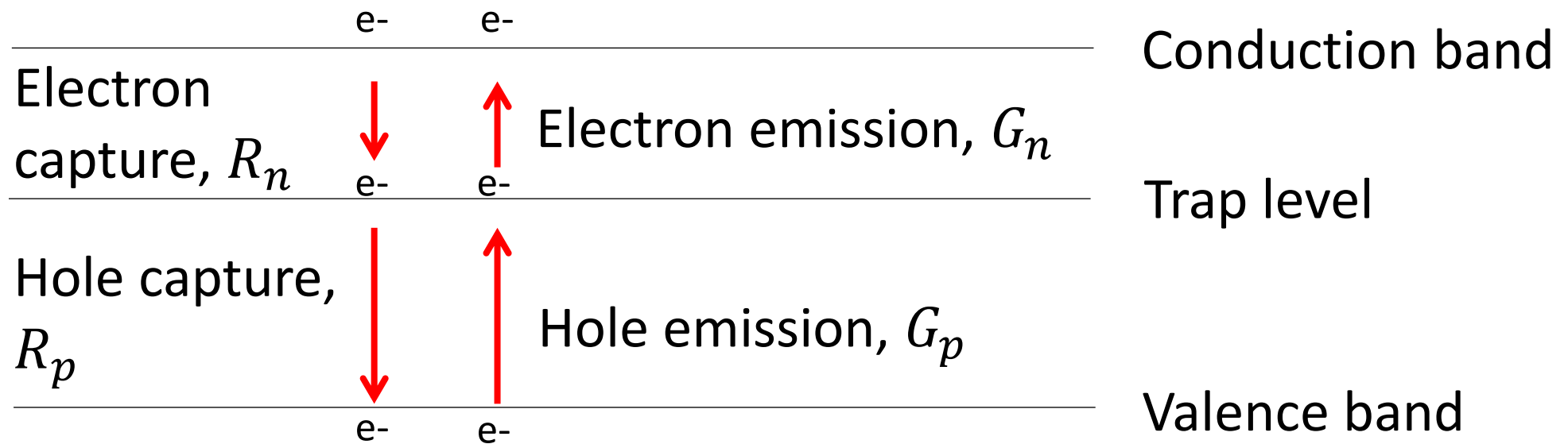
- When the generation and recombination processes are considered,

– We need additional terms.

$$\frac{\partial n}{\partial t} = -\nabla \cdot \mathbf{F}_n + G_n - R_n$$

SRH (Shockley-Read-Hall) recombination (1)

- In silicon, a *radiative* or *Auger* process is very low due to its indirect bandgap.
 - Most of the recombination processes take place indirectly via a trap or a deep impurity level near the middle of the forbidden gap.



SRH (Shockley-Read-Hall) recombination (2)

- After some derivation steps,
 - We have the following expression:

$$R_n - G_n = R_p - G_p = \frac{np - n_i^2}{\tau_p(n + n_1) + \tau_n(p + p_1)}$$

Taur, Eq. (A5.16)

- It vanishes at equilibrium.

Full set of equations

- Drift-diffusion model

- Poisson equation

$$\nabla \cdot (\epsilon \mathbf{E}) = q(p - n + N_d^+ - N_a^-)$$

- Continuity equations

$$\frac{\partial n}{\partial t} = \frac{1}{q} \nabla \cdot \mathbf{J}_n + G_n - R_n$$

Taur, Eq. (2.68)

$$\frac{\partial p}{\partial t} = -\frac{1}{q} \nabla \cdot \mathbf{J}_p + G_p - R_p$$

Taur, Eq. (2.69)

- Current density

$$\mathbf{J}_n = q\mu_n n \mathbf{E} + qD_n \nabla n, \quad \mathbf{J}_p = q\mu_p p \mathbf{E} - qD_p \nabla p$$

Dielectric relaxation time

- Consider a homogeneous n-type sample. (Neglect g-r processes.) Assume $\Delta n(\mathbf{r})$.

- In the first order,

$$\Delta \mathbf{J}_n = q\mu_n(\Delta n)\mathbf{E} + q\mu_n n(\Delta \mathbf{E}) + qD_n \nabla(\Delta n)$$

- Electron continuity equation

$$\frac{\partial}{\partial t} \Delta n = \frac{1}{q} \nabla \cdot \Delta \mathbf{J}_n \approx \nabla \cdot [\mu_n n(\Delta \mathbf{E})] = \mu_n n \frac{(-q)\Delta n}{\epsilon} \quad \text{Taur, Eq. (2.70)}$$

- The dielectric relaxation time, $\frac{\epsilon}{q\mu_n n}$

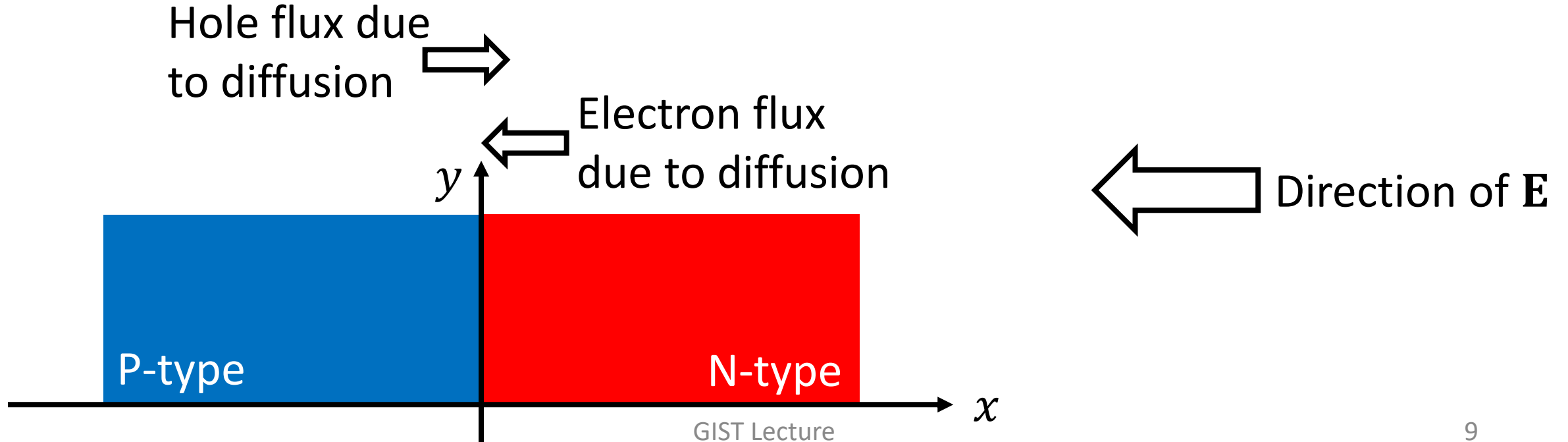
- The majority-carrier response time in silicon is typically on the order of 10^{-12} sec, which is shorter than most device switching times.

PN junction

- Where can we find PN junctions?

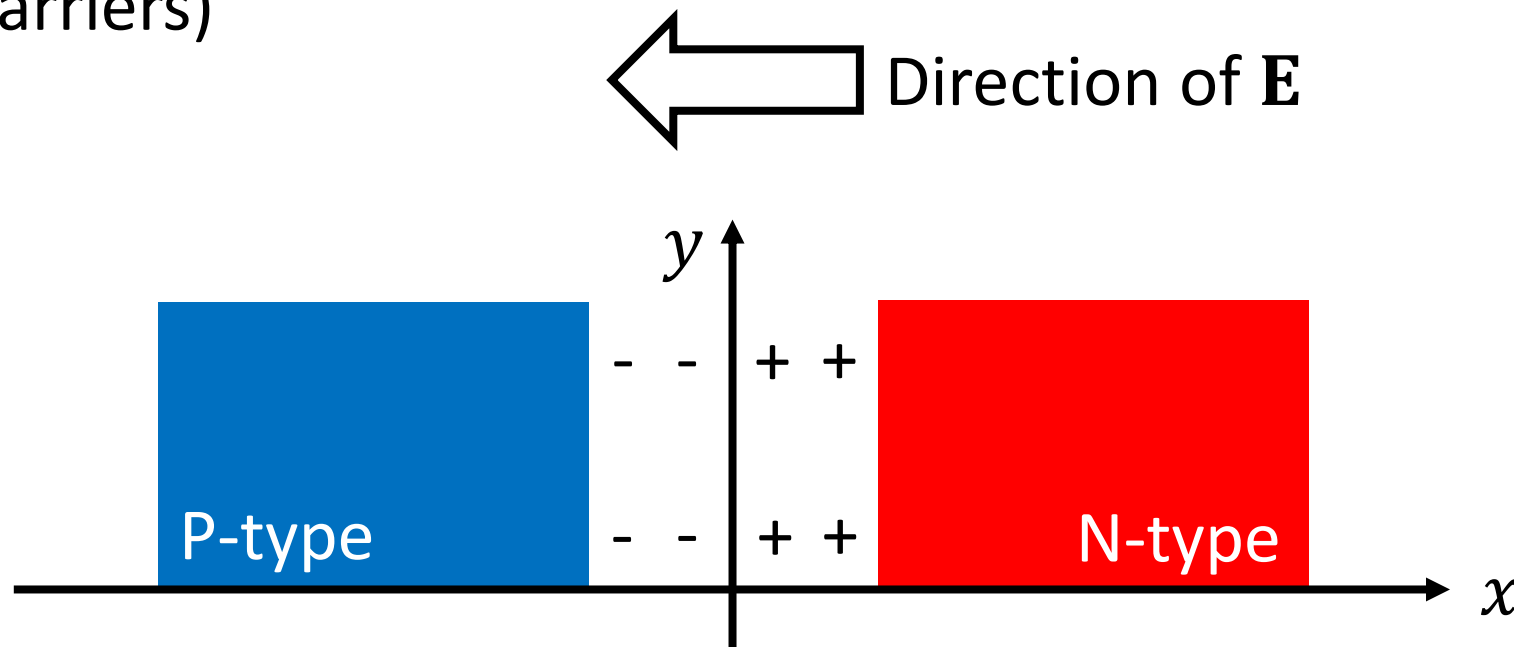
Qualitative description (1)

- Built-in electric field
 - Strong diffusion current density
 - At equilibrium, the net flux must vanish.
 - An electric field is required.



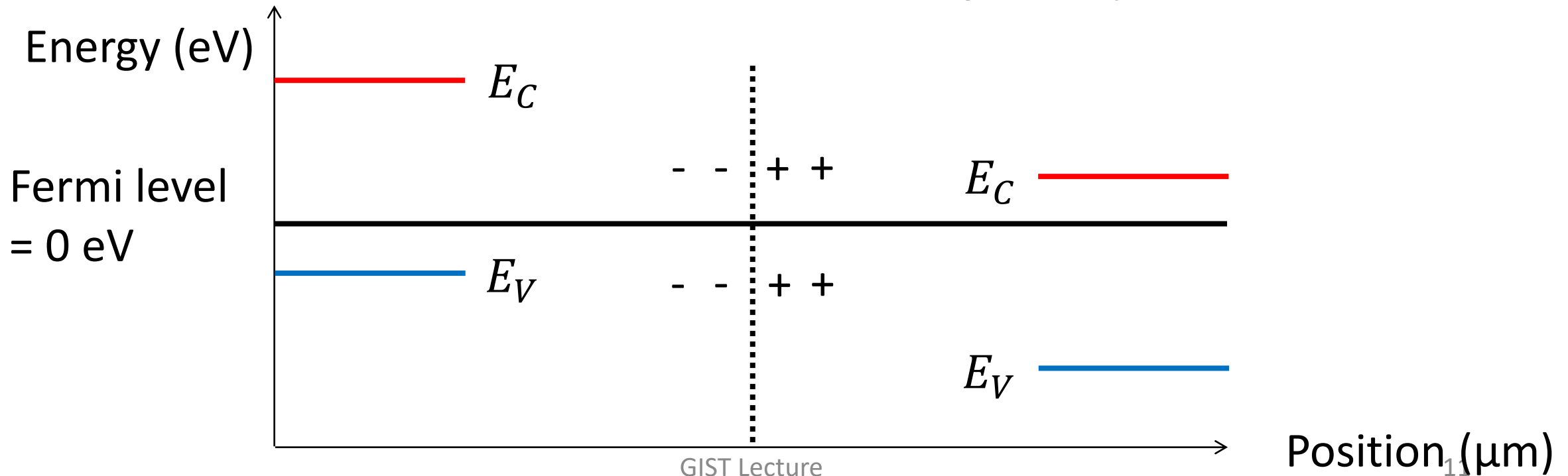
Qualitative description (2)

- How to build an electric field
 - We need the net charge density, ρ .
 - Positive charges in the n-type region, negative p-type
 - These charges can be supplied by the depletion layer. (Eliminating charge carriers)



Energy band diagram at equilibrium

- At thermal equilibrium, the Fermi level must remain flat across the entire pn junction.
 - Away from the junction, the energy bands are flat.
 - Near the junction, a smooth transition of E_C and E_V



Built-in potential

- Assume that N_d is the donor density and N_a is the acceptor density.

- In the n-type boundary,

$$N_d = n_i \exp \frac{\phi}{k_B T / q}, \quad \phi = \frac{k_B T}{q} \ln \left(\frac{N_d}{n_i} \right) \quad \text{Taur, Eq. (2.71)}$$

- In the p-type boundary,

$$N_a = n_i \exp \frac{-\phi}{k_B T / q}, \quad \phi = -\frac{k_B T}{q} \ln \left(\frac{N_a}{n_i} \right) \quad \text{Taur, Eq. (2.72)}$$

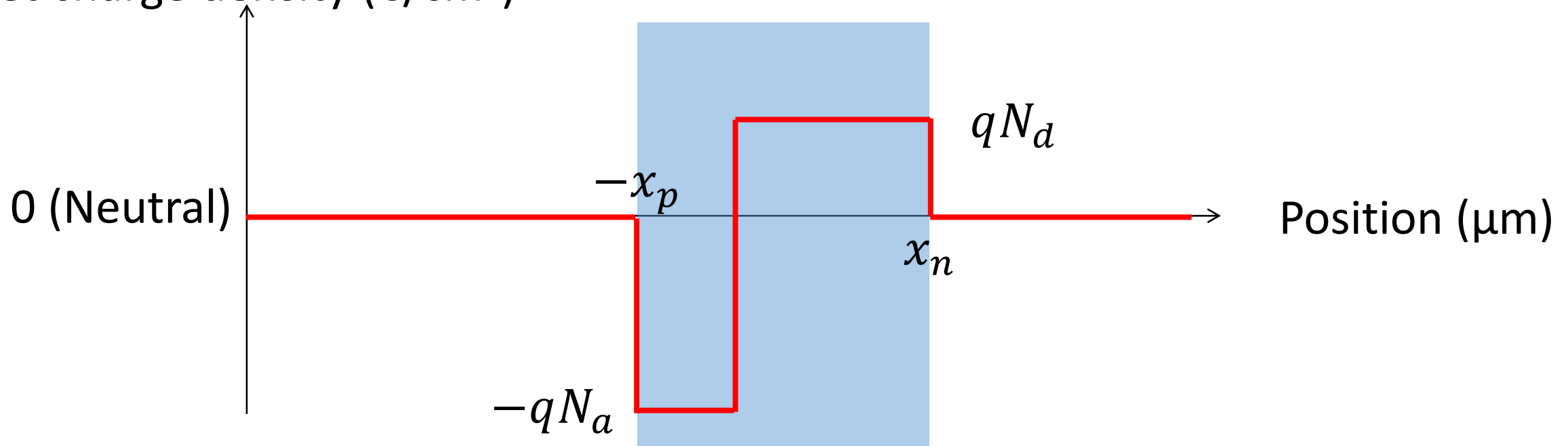
- Their difference, the built-in potential (ϕ_{bi}) is

$$\phi_{bi} = \frac{k_B T}{q} \ln \left(\frac{N_d N_a}{n_i^2} \right) \quad \text{Taur, Eq. (2.73)}$$

Depletion approximation

- Electron and hole densities are assumed to be negligible in the entire band-bending region.
 - Depletion region(/layer) from $-x_p$ to x_n . $N_a x_p = N_d x_n$

Net charge density (C/cm³)



Analytic solution

- The Poisson equation in the depletion region

$$\frac{d^2\phi}{dx^2} = \frac{q}{\epsilon} N_a$$

Taur, Eq. (2.77)

$$\frac{d^2\phi}{dx^2} = -\frac{q}{\epsilon} N_d$$

Taur, Eq. (2.76)

- Assuming vanishing electric fields at $-x_p$ and x_n ,

$$\left| \frac{d\phi}{dx} \right|_{x=0} = \frac{q}{\epsilon} N_d x_n = \frac{q}{\epsilon} N_a x_p$$

Taur, Eq. (2.78)

Thank you!